

## Processing and Packaging Technologies for Photonic Integration (E030450)

**Course size** *(nominal values; actual values may depend on programme)*

**Credits 4.0** **Study time 120 h**

**Course offerings in academic year 2025-2026**

A (semester 2) English Gent

**Lecturers in academic year 2025-2026**

Van Steenberge, Geert	TW06	lecturer-in-charge
Missinne, Jeroen	TW06	co-lecturer

**Offered in the following programmes in 2025-2026**

<a href="#">Master of Science in Silicon Photonics</a>	<b>crdts</b>	<b>offering</b>
	4	A

**Teaching languages**

English

**Keywords**

Semiconductor technologies, packaging

**Position of the course**

Expose the students to various fabrication and packaging concepts necessary for PICs

**Contents**

**Introduction**

iSiPP50G Silicon Photonics Platform

**Semiconductor Technologies**

Crystal Growth

    Silicon Crystal Growth from the Melt

    Starting Material

The Czochralski Technique

Distribution of Dopant

    Silicon float-zone process

    Material Characterization

    Wafer Shaping

Crystal Characterization

Silicon Oxidation

    Thermal Oxidation Process

    Impurity Redistribution During Oxidation

    Masking Properties of Silicon Dioxide

    Oxide Quality

    Oxide Thickness Characterization

Photolithography

    Optical Lithography

    The Clean Room

Exposure Tools

Masks

Photoresist

Pattern Transfer

Resolution

    Next-Generation Lithography Methods

    Electron Beam Lithography

Extreme Ultraviolet Lithography

- Etching
  - Wet Chemical Etching
    - Silicon Etching
  - Silicon Dioxide Etching
  - Silicon Nitride Etching
    - Aluminum Etching
  - Dry Etching
    - Plasma Fundamentals
- Etch Mechanism
- Plasma Diagnostics
- End-Point Control
- Reactive Plasma Etching Applications
- Diffusion
  - Basic Diffusion Process
    - Diffusion Equation
- Diffusion Profiles
  - Extrinsic Diffusion
- Ion Implantation
  - Range of Implanted Ions
    - Ion Distribution
- Ion Stopping
- Ion Channeling
  - Implant Damage and Annealing
- Film Deposition
  - Epitaxial Growth Techniques
    - Chemical Vapor Deposition
- Molecular Beam Epitaxy
  - Structures and Defects in Epitaxial Layers
    - Lattice-Matched and Strained-Layer Epitaxy
- Defects in Epitaxial Layers
  - Dielectric Deposition
    - Silicon Dioxide
- Silicon Nitride
  - Metallization
    - Physical Vapor Deposition
- Chemical Vapor Deposition
- Aluminum Metallization
  - Copper Metallization
- Fabrication of Silicon Waveguide Devices
- Silicon-on-Insulator
  - Separation by Implanted Oxygen (SIMOX)
  - Bond and Etch-Back SOI
  - Wafer Splitting
- Selected Components from iSiPP50G Silicon Photonics Platform
  - Silicon Waveguides
- Modulators
- Photodiodes
- Grating couplers
- Packaging Technologies**
- Optical Packaging
  - Fiber-Coupling
    - Grating-Coupling
    - Edge-Coupling
  - Fiber-Array Attach
- V-groove Integration
- Laser Integration
  - Micro-Packaged Lasers
    - Die Bonding
      - Flip-Chip Bonding
    - Transfer Printing
- Micro-Optics Integration
  - 3D Nano-Printing
- High-accuracy Pick-and-Place

Monolithic Micro-Optics Integration  
Electrical Packaging  
Wire Bonding  
Flip-Chip Bumping and Bonding  
Hybrid Bonding  
Wafer-Level Packaging  
    2D Integration Using Organic Interposers  
2.5D Integration Using Silicon Interposers with TSVs  
3D Integration  
Fanout Wafer-Level Packaging  
Micro-Chiplets  
Thermal Packaging  
    Thermal Interface Materials  
    Thermo-Electric Cooling

#### **Initial competences**

Basic optics and electromagnetics

#### **Final competences**

- 1 Understanding of different semiconductor process steps like crystal growth, oxidation, photolithography, etching, diffusion, ion implantation, and film deposition
- 2 Understanding of the fabrication of the most important integrated photonics components
- 3 Understanding of different photonics packaging processes like fiber array attach; laser integration, micro-optics integration, wire and flip-chip bonding, wafer-level packaging, thermal packaging.
- 4 Critical reading and understanding of a scientific article
- 5 Hands-on experience with a number of process steps in a clean room environment.
- 6 Development of a custom PIC package

#### **Conditions for credit contract**

Access to this course unit via a credit contract is determined after successful competences assessment

#### **Conditions for exam contract**

This course unit cannot be taken via an exam contract

#### **Teaching methods**

Lecture, Practical, Independent work

#### **Extra information on the teaching methods**

Lectures, cleanroom project, independent work

#### **Study material**

Type: Slides

Name: Slides and course notes used during the course

Indicative price: Free or paid by faculty

Optional: no

Additional information: Available electronically (free)

#### **References**

- [1] May, Gary S.; Sze, Simon M. Fundamentals of Semiconductor Fabrication, John Wiley and Sons, 2004.
- [2] C.Y. Chang and S.M. Sze. ULSI Technology, McGraw-Hill, 1996.
- [3] C.Y. Chang and S.M. Sze. ULSI Devices, John Wiley and Sons, 2000.
- [4] S.M. Sze. VLSI Technology, McGraw-Hill, 1988.
- [5] H. Zimmermann. Silicon Optoelectronic Integrated Circuits, Springer, 2004.

#### **Course content-related study coaching**

4 researchers

#### **Assessment moments**

end-of-term and continuous assessment

#### **Examination methods in case of periodic assessment during the first examination period**

Oral assessment

**Examination methods in case of periodic assessment during the second examination period**

Oral assessment

**Examination methods in case of permanent assessment**

Oral assessment

**Possibilities of retake in case of permanent assessment**

examination during the second examination period is possible in modified form

**Extra information on the examination methods**

- During examination period: oral closed-book assessment.
- During semester: periodic and permanent evaluation. Presentation about a project focusing on fabrication and packaging

**Calculation of the examination mark**

70% oral exam, 30% presentation.